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Application/Control No.	Applicant(s)/Patent under Reexamination
09/913,430	UNO ET AL.
Examiner	Art Unit
Jorge L. Ortiz-Criado	2655

SEARCHED			
Class	Subclass	Date	Examiner
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOT (INCLUDING SEARCH)
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TEXT/Subdess search 369/283,286,288,275.1 E75.2 428/64.1,64.2,64.4 see print out		9
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